



# AOD409/AOI409

# P-Channel Enhancement Mode Field Effect Transistor

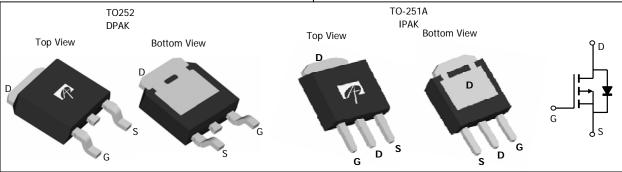
# **General Description**

The AOD/I409 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and low gate resistance. With the excellent thermal resistance of the DPAK package, this device is well suited for high current load applications.

## **Features**

$$\begin{split} &V_{DS}\left(V\right) = -60V \\ &I_{D} = -26A\left(V_{GS} = -10V\right) \\ &R_{DS(ON)} < 40m\Omega\left(V_{GS} = -10V\right) \textcircled{20} -20A \\ &R_{DS(ON)} < 55m\Omega\left(V_{GS} = -4.5V\right) \end{split}$$

UIS TESTED! Rg,Ciss,Coss,Crss Tested



Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		$V_{DS}$	-60	V				
Gate-Source Voltage		$V_{GS}$	±20	V				
Continuous Drain	T <sub>C</sub> =25°C		-26					
Current <sup>G</sup>	T <sub>C</sub> =100°C	I <sub>D</sub>	-18	A				
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	-60	$\neg$				
Avalanche Current <sup>C</sup>		I <sub>AR</sub>	-26	Α				
Repetitive avalanche energy L=0.1mH <sup>C</sup>		E <sub>AR</sub>	33.8	mJ				
	T <sub>C</sub> =25°C	В	60	W				
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100°C	$-P_{D}$	30	T vv				
	T <sub>A</sub> =25°C	В	2.5	10/				
Power Dissipation <sup>A</sup>	T <sub>A</sub> =70°C	P <sub>DSM</sub>	1.6	W				
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C				

Thermal Characteristics									
Parameter	Symbol	Тур	Max	Units					
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s Steady-State R <sub>θJA</sub>		16.7	25	°C/W				
Maximum Junction-to-Ambient <sup>A</sup>			40	50	°C/W				
Maximum Junction-to-Case <sup>C</sup>	Steady-State	$R_{ heta JC}$	1.9	2.5	°C/W				

#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

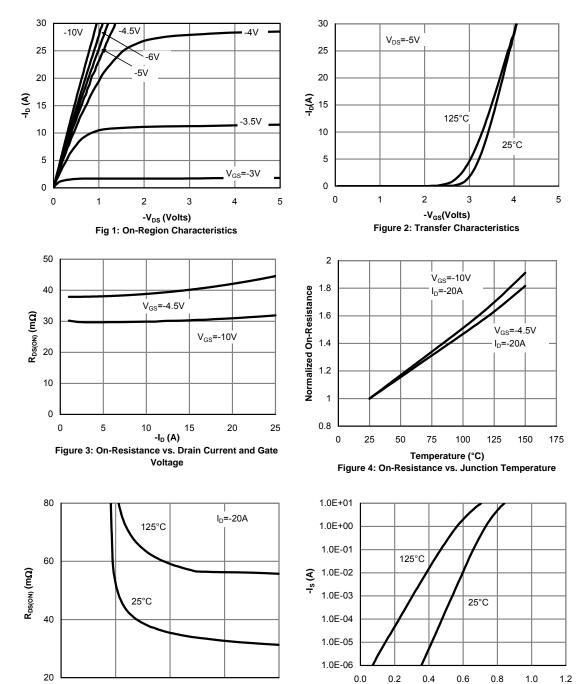
Symbol	Parameter	Conditions		Тур	Max	Units
STATIC P	ARAMETERS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-60			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-48V, V <sub>GS</sub> =0V		-0.003	-1 -5	μА
I <sub>GSS</sub>	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=-250\mu A$	-1.2	-1.9	-2.4	V
$I_{D(ON)}$	On state drain current	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V	-60			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A		32	40	mΩ
		T <sub>J</sub> =125°C		53		1115.2
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-20A		43	55	mΩ
9 <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =-5V, $I_D$ =-20A		32		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =-1A,V <sub>GS</sub> =0V		-0.73	-1	V
Is	Maximum Body-Diode Continuous Current				-30	Α
DYNAMIC	PARAMETERS					
C <sub>iss</sub>	Input Capacitance			2977	3600	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =-30V, f=1MHz		241		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			153		pF
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		2	2.4	Ω
SWITCHII	NG PARAMETERS					
Q <sub>g</sub> (10V)	Total Gate Charge			44	54	nC
$Q_g(4.5V)$	Total Gate Charge	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-30V, I <sub>D</sub> =-20A		22.2	28	nC
$Q_{gs}$	Gate Source Charge	Vgs- 10 V, Vbs- 00 V, 1b- 20/1		9		nC
$Q_{gd}$	Gate Drain Charge			10		nC
t <sub>D(on)</sub>	Turn-On DelayTime			12		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =-10V, $V_{DS}$ =-30V, $R_L$ =1.5 $\Omega$ ,		14.5		ns
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		38		ns
t <sub>f</sub>	Turn-Off Fall Time			15		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	$I_F$ =-20A, dI/dt=100A/ $\mu$ s		40	50	ns
$Q_{rr}$	Body Diode Reverse Recovery Charge I <sub>F</sub> =-20A, dl/dt=100A/μs			59		nC

A: The value of R qJA is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with T  $_{\rm A}$  =25°C. The Power dissipation PDSM is based on R  $_{\rm 0JA}$  and the maximum allowed junction temperature of 150°C. The value in any a given application depends on the user's specific board design, and the maximum temperature fo 175°C may be used if the PCB allows it.

- B. The power dissipation PD is based on  $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C: Repetitive rating, pulse width limited by junction temperature T  $_{\text{J(MAX)}}$ =175°C.
- D. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to case R qJC and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300 ms pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T  $_{J(MAX)}$ =175°C.
- G. The maximum current rating is limited by bond-wires.
- H. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T  $_{\rm A}$ =25°C. The SOA curve provides a single pulse rating.
- \*This device is guaranteed green after data code 8X11 (Sep 1  $^{\rm ST}$  2008). Rev 5: Jan 2011

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



6

-V<sub>GS</sub> (Volts)

Figure 5: On-Resistance vs. Gate-Source Voltage

8

10

-V<sub>SD</sub> (Volts)

Figure 6: Body-Diode Characteristics

2



- ▶ 汇集 8,000 家半导体厂商,坐拥 70,000,000 个电子元器件 datasheet
- 涉及详细参数,器件、封装、应用图,参考设计,中文PDF。
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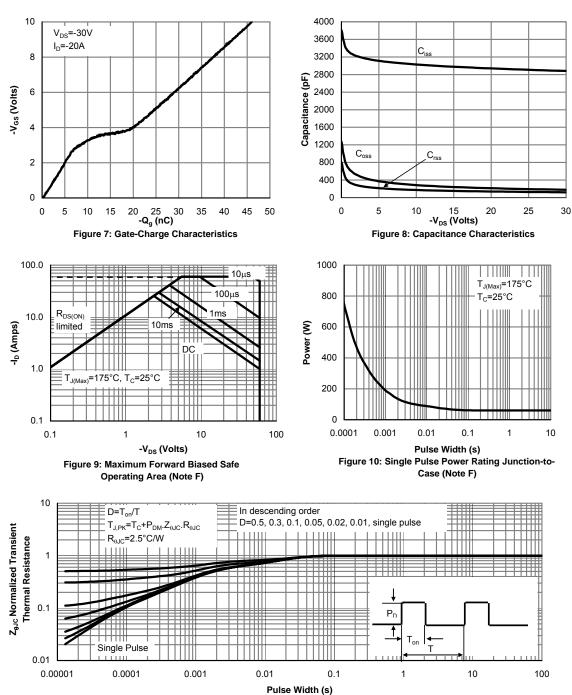


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

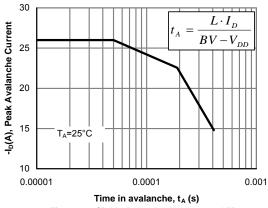


Figure 12: Single Pulse Avalanche capability

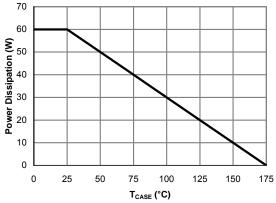


Figure 13: Power De-rating (Note B)

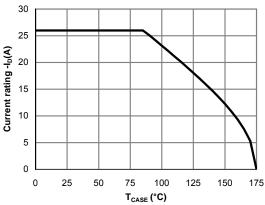


Figure 14: Current De-rating (Note B)

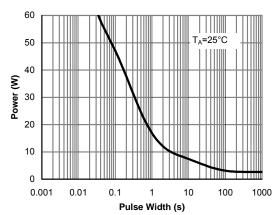


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

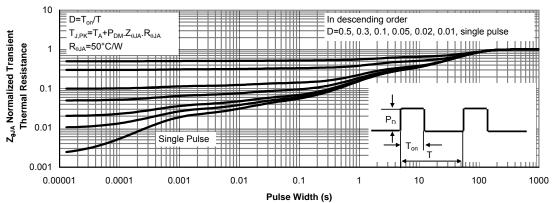
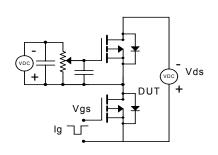
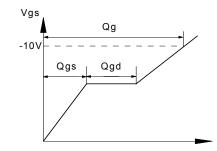


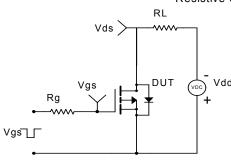
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

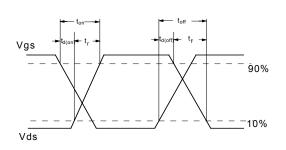
## Gate Charge Test Circuit & Waveform



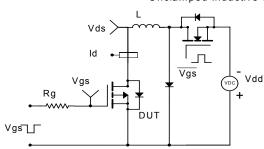


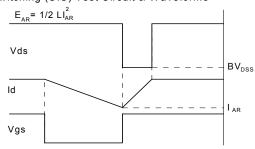
Resistive Switching Test Circuit & Waveforms





# Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





## Diode Recovery Test Circuit & Waveforms

